

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	3064	(multiplex\$3 select\$4) near (three and inputs)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/06 15:39
S2	205	((multiplex\$3 select\$4) near (three and inputs)) and (test\$3 adj (circuit integrated scan chain))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/04/07 14:42
S3	111	((multiplex\$3 select\$4) near (three and inputs)) and (test\$3 adj (circuit integrated scan chain)) and (test near mode)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/04/07 14:46
S4	0	((multiplex\$3 select\$4) near (three and inputs)) and (test\$3 adj (circuit integrated scan chain)) and (test near mode) and (target near circuit)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/04/07 14:46
S5	0	(((multiplex\$3 select\$4) near (three and inputs)) and (test\$3 adj (circuit integrated scan chain)) and (test near mode)).ab. (((multiplex\$3 select\$4) near (three and inputs)) and (test\$3 adj (circuit integrated scan chain)) and (test near mode)).ti. (((multiplex\$3 select\$4) near (three and inputs)) and (test\$3 adj (circuit integrated scan chain)) and (test near mode)).clm.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/04/07 14:47
S6	12	"5768289"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/06 15:39
S7	2	"5768289".pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/07 13:35
S8	26	("5768289" "6189128" "6079039" "5627841" "5680406" "6000051" "6223315" "6122762" "5960008" "6324662" "5710867" "6134675" "5847561").pn.	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/07 13:37

S9	24	("5768289" "6189128" "6079039" "5627841" "5680406" "6000051" "6223315" "6122762" "5960008" "6324662" "5710867" "6134675" "5847561").pn. and (multiplex\$4 compar\$3 test\$3 first second target circuit pattern external stor\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/12/07 13:39
S10	13	("5768289" "6189128" "6079039" "5627841" "5680406" "6000051" "6223315" "6122762" "5960008" "6324662" "5710867" "6134675" "5847561").pn. and (multiplex\$4 compar\$3 test\$3 first second target circuit pattern external stor\$3)	USPAT; USOCR	OR	ON	2004/12/07 14:05
S11	3641	(test\$3 with ((first second) near circuits))	USPAT; USOCR	OR	ON	2004/12/07 14:06
S12	632	(test\$3 with ((first second) near circuits)) and ((first second third) near (select\$3 multiplex\$3)))	USPAT; USOCR	OR	ON	2004/12/07 14:13
S13	7	((test\$3 with ((first second) near circuits)) and ((first second third) near (select\$3 multiplex\$3))).ab.	USPAT; USOCR	OR	ON	2004/12/07 14:07
S14	195	((test\$3 with ((first second) near circuits)) and ((first second third) near (select\$3 multiplex\$3))).clm.	USPAT; USOCR	OR	ON	2004/12/07 14:07
S15	49	((test\$3 with ((first second) near circuits)).and ((first second third) near (select\$3 multiplex\$3))) and 714/724.ccls.	USPAT; USOCR	OR	ON	2004/12/07 14:07
S16	2	((test\$3 with ((first second) near circuits)) and ((first second third) near (select\$3 multiplex\$3))) and 714/742.ccls.	USPAT; USOCR	OR	ON	2004/12/07 14:12
S17	173	(test\$3 with ((first second) near circuits)) same ((first second third) near (select\$3 multiplex\$3)))	USPAT; USOCR	OR	ON	2004/12/07 14:14
S18	5	(test\$3 with ((first and second) near circuits)) same ((first and second and third) near (select\$3 multiplex\$3)))	USPAT; USOCR	OR	ON	2004/12/07 14:20
S19	1	"6523135".pn.	USPAT; USOCR	OR	ON	2004/12/07 14:22
S20	1	"6381720" .pn.	USPAT; USOCR	OR	ON	2004/12/07 14:24
S21	1	"6079039".pn.	USPAT; USOCR	OR	ON	2004/12/07 14:24